

# Mitigating Global Failure Regimes in Large Distributed Systems (Ongoing Research)

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**No effective methods exist to predict failure regimes in large distributed systems—the search space is large and causality is difficult to establish. Our research goals are to: (1) develop design-time methods that system engineers can use to detect existence and causes of costly failure regimes prior to system deployment and (2) develop run-time methods that system managers can use to detect onset of costly failure regimes in deployed systems, prior to collapse.**

**First  
Hard  
Problem**

Complex information systems encompass an infeasible search space.

$$y_1, \dots, y_m = f(x_1 | [1, \dots, k], \dots, x_n | [1, \dots, k])$$

System Response Space      System Parameter Space

System Parameter Space =  $k^x$ , e.g., for  $k$  of  $2^{32}$  and  $x$  of 1000, =  $(2^{32})^{1000} = O(10^{9633})$

Atoms in the visible universe = about  $10^{80}$

Determining causality is difficult given only patterns of global system behavior.

For example, unexpected collapse in the mitigation probability density function of job completion times in a computing grid was unexplainable without more detailed data and analysis.

**Second  
Hard  
Problem**

## Approach One: Combine Markov Models, Graph Analysis and Perturbation Analysis

**Using simulated failure scenarios in a Markov chain model to predict failures in a Cloud**

Example: Markov simulation and perturbation of a minimal s-t cut set of a Markov chain graph:

- Corresponds to software failure scenario involving multiple faults/attacks.
- Simulation identifies threshold beyond which increased failure incidence causes drastic performance collapse

→ Verified in target system being modeled (i.e., Koala, a large-scale simulation of a Cloud)

## Approach Two: Combine Anti-Optimization and Genetic Algorithms

MULTIDIMENSIONAL ANALYSIS TECHNIQUES

Principal Components Analysis, Clustering, ...

GENETIC ALGORITHM

Recombination & Mutation      Selection based on Anti-Fitness

Anti-Fitness Reports

MODEL SIMULATORS

Parallel Execution of Model Simulators

Population of Model Parameterizations

List of parameters and for each parameter a MIN, MAX and precision.

Model Parameter Specifications

Growing Collection of Tuples:

(Generation, Individual, Fitness, Parameter 1 value, ..., Parameter N value)

## Approach Three: Measuring Key System Properties such as Critical Slowing Down

A simple univariate example predicting power grid blackout in a human engineered system\*

(1) Measured frequency

(2) Frequency after detrending

(3) Critical slowing down measured by rise in autocorrelation in detrended data

Phase transition to blackout

Time before critical transition (minutes)

\*From P. Hines, E. Cotilla-Sanchez, and S. Blumsack. Topological Models and Critical Slowing Down: Two Approaches to Power System Risk Analysis. Proceedings of the 4th Hawaii Conference on System Sciences. IEEE Computer Society, Washington, DC, USA, pp. 1-10.

## How might your organization benefit from collaborating with us?

- **IF** your organization designs and deploys Clouds and other large distributed systems **AND**
  - You wish to improve the reliability of your system **AND**
  - You have a model of your system **OR**
  - You are willing to share sufficient information for us to construct a model **AND** you are willing to help us ensure our model suitability represents your system
- **THEN** working together we could help you improve the reliability of your system (or specific aspects of your system) by:
  - Applying our design-time methods to search the design space for potential collapse scenarios (and iterating on any proposed design revisions you create to mitigate collapse scenarios) **AND/OR**
  - Exploring run-time monitoring and measurement approaches that could signal incipient onset of collapse scenarios that were not detected using our design-time methods

**WIN-WIN:** we would gain additional evaluation and refinement of our methods and you could gain a transfer of our technology to enhance your design process.